

## GENERAL DESCRIPTION

The BW1218L is a CMOS 10-bit analog-to-digital converter (ADC). It converts the analog input signal into 10bit binary digital codes at a maximum sampling rate of 10MHz.

The device is a monolithic ADC with an on-chip, high-performance, sample-and-hold Amplifier (SHA) and current reference. The structure allows single-ended input for simple interface.

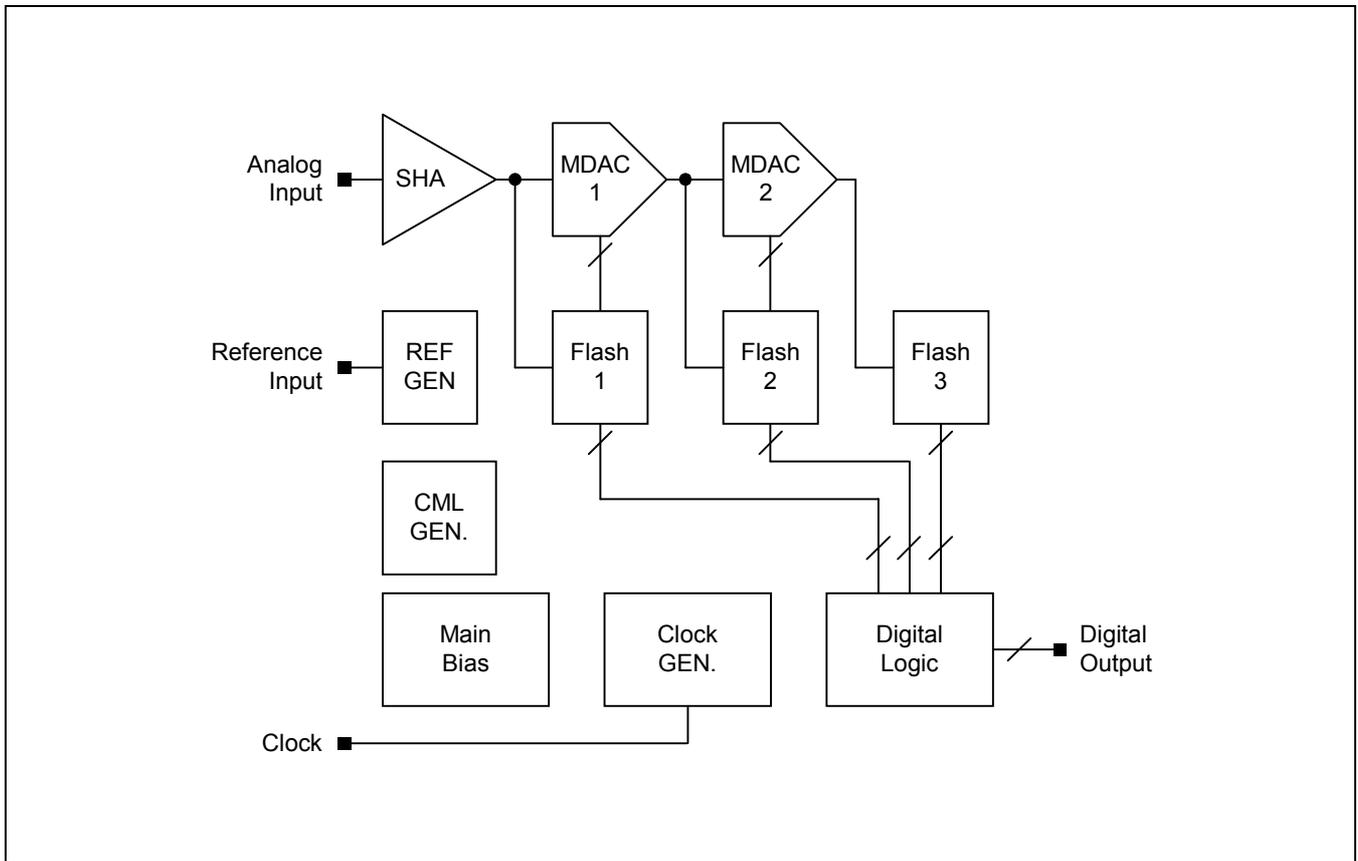
## TYPICAL APPLICATIONS

- HDD Engine
- Multi-Media (CDP)
- Low Power Application

## FEATURES

- Resolution: 10-bit
- Maximum Conversion Rate: 10MHz
- Package Type: 48TSSOP
- Power Supply: 3.3V
- Power Consumption: 40mW (typical)
- Reference Voltage: 3.2V (single reference)
- Input Range: 0V ~ 3.0V (3.0VP-P)
- Differential Linearity Error:  $\pm 0.7$  LSB
- Integral Linearity Error:  $\pm 1.1$  LSB
- Signal to Noise & Distortion Ratio : 54dB
- Digital Output: CMOS Level
- Operating Temperature Range : 0 °C ~ 70 °C

### FUNCTIONAL BLOCK DIAGRAM



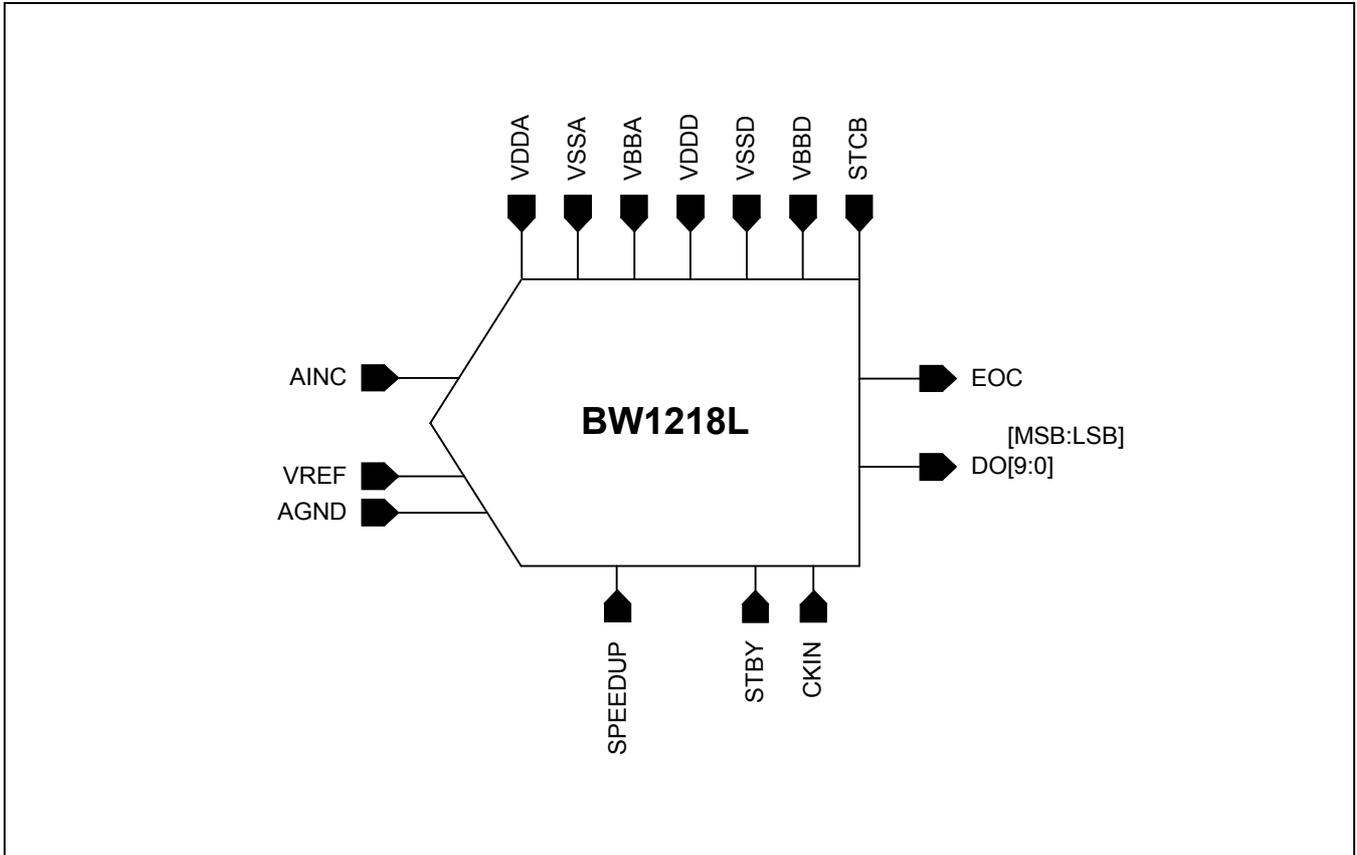
**CORE PIN DESCRIPTION**

Name	I/O Type	I/O Pad	Pin Description
VREF	AI	pia_bb	Reference Voltage (3.2V)
AGND	AI	pia_bb	Analog Ground for Reference
VDDA	AP	vdda	Analog Power (3.3V)
VBBA	AG	vbba	Analog Sub Bias
VSSA	AG	vssa	Analog Ground
AINT	AI	piar50_bb	Analog Input (Input Range: 0.0V ~ 3.0V)
SPEEDUP	DI	picc_bb	VDD=Speed up, GND=Normal
STBY	DI	picc_bb	VDD=power saving (standby), GND=normal
CKIN	DI	picc_bb	Sampling Clock Input
DO[9:0]	DO	pot4_bb	Digital Output
EOC	DO	pot4_bb	End of Conversion Signal
STCB	DI	picc_bb	Start of Conversion Signal
VBBD	DG	vbba	Digital Sub Bias
VSSD	DG	vssd	Digital GND
VDDD	DP	vddd	Digital Power (3.3V)

**I/O Type Abbr.**

- AI: Analog Input
- DI: Digital Input
- AO: Analog Output
- DO: Analog Output
- AP: Analog Power
- AG: Analog Ground
- DP: Digital Power
- DG: Digital Ground
- AB: Analog Bidirection
- DB: Digital Bidirection

CODE CONFIGURATION



## ABSOLUTE MAXIMUM RATINGS

Characteristics	Symbol	Value	Unit
Supply Voltage	VDD	4.5	V
Analog Input Voltage	AIN	VSS to VDD	V
Digital Input Voltage	CKIN	VSS to VDD	V
Reference Voltage	VREF/AGND	VSS to VDD	V
Storage Temperature Range	Tstg	-45 to 150	°C
Operating Temperature Range	Topr	0 to 70	°C

### NOTES

1. ABSOLUTE MAXIMUM RATING specifies the values beyond which the device may be damaged permanently. Exposure to ABSOLUTE MAXIMUM RATING conditions for extended periods may affect reliability. Each condition value is applied with the other values kept within the following operating conditions and function operation under any of these conditions is not implied.
2. All voltages are measured with respect to VSS unless otherwise specified.
3. 100pF capacitor is discharged through a 1.5kΩ resistor (Human body model)

## RECOMMENDED OPERATING CONDITIONS

Characteristics	Symbol	Min	Typ	Max	Unit
Supply Voltage	VDDD VDDA VDDR	3.15	3.3	3.45	V
Reference Input Voltage	VREF		3.2		V
Analog Input Voltage	AIN	0.0		3.0	V
Operating Temperature	Topr	0	–	70	°C

**NOTE:** It is strongly recommended that all the supply pins (VDDA, VDDD, VDDR) be powered from the same source to avoid power latch-up.

**DC ELECTRICAL CHARACTERISTICS**

Characteristics	Symbol	Min	Typ	Max	Unit	Test Condition
Differential Nonlinearity	DNL	–	$\pm 0.7$	$\pm 1$	LSB	VREF = 3.2V AINT = 0.0 ~ 3.0V
Integral Nonlinearity	INL	–	$\pm 1.1$	$\pm 2$	LSB	VREF = 3.2V AINT = 0.0 ~ 3.0V
Offset Voltage	OFF	–	–	30	LSB	VREF = 3.2V

**NOTE:** Converter Specifications: VDDA=VDDD=VDDR=3.3V, VSSA=VSSD=VSSR=0V,  
Toper=25 °C, REFTOP=2V, REFBOT=1V unless otherwise specified

**AC ELECTRICAL CHARACTERISTICS**

Characteristics	Symbol	Min	Typ	Max	Unit	Test Condition
Maximum Conversion Rate	fc	–	5	10	MHz	AIN = 500kHz AINT = 0.0 ~ 3.0V
Dynamic Supply Current	IVDD	–	12	16	mA	fc = 5MHz (without system load)
Signal-to-Noise & Distortion Ratio	SNDR	46	50	–	dB	AIN = 500kHz AINT = 0.0 ~ 3.0V

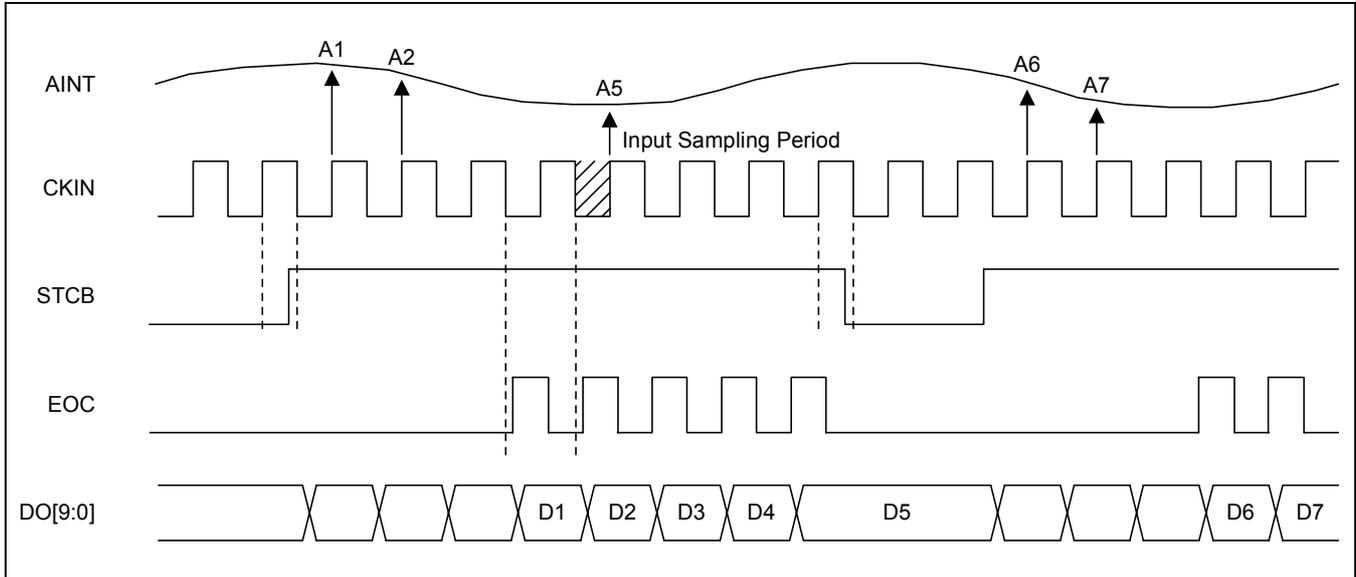
**NOTE:** Converter Specifications: VDDA=VDDD=VDDR=3.3V, VSSA=VSSD=VSSR=0V,  
Toper=25 °C, REFTOP=2V, REFBOT=1V unless otherwise specified

**I/O CHART**

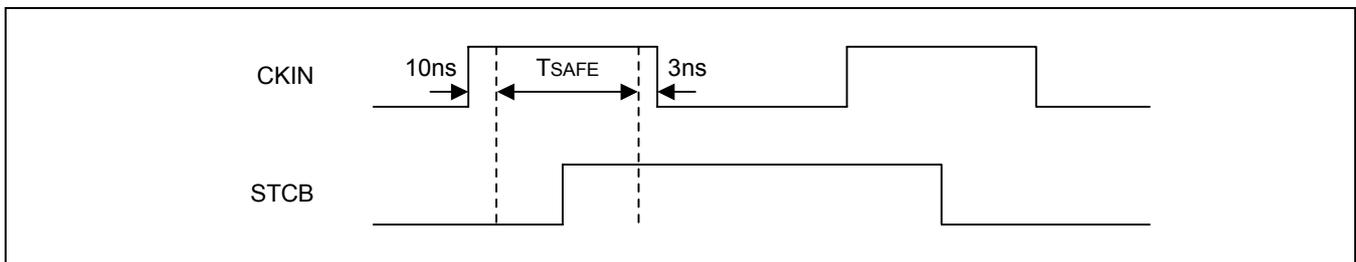
Index	AIN Input (V)	Digital Output	
0	0.00000 ~ 0.00293	000000000	1LSB=2.93mV VREF=3.2V
1	0.00293 ~ 0.00586	000000001	
2	0.00586 ~ 0.00879	000000010	
~	~	~	
511	1.49707 ~ 1.50000	011111111	
512	1.50000 ~ 1.50293	100000000	
513	1.50293 ~ 1.50586	100000001	
~	~	~	
1021	2.99121 ~ 2.99414	111111101	
1022	2.99414 ~ 2.99707	111111110	
1023	2.99707 ~ 3.00000	111111111	

## TIMING DIAGRAM

### 1. Main Waveform

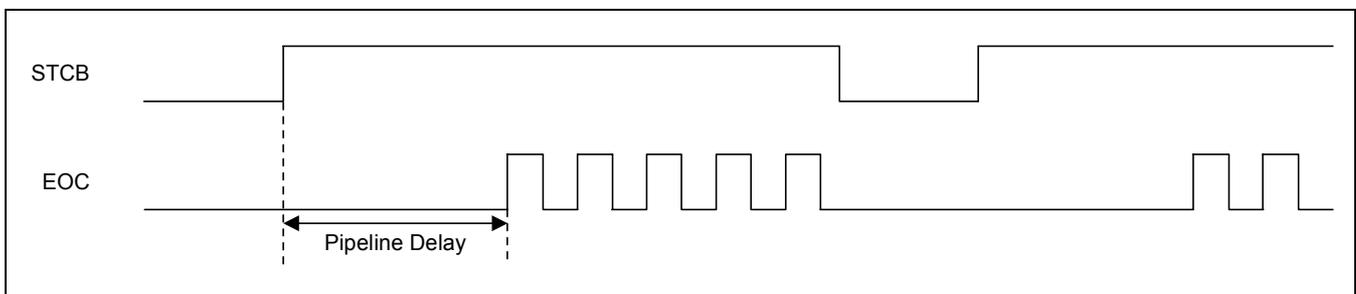


### 2. STCB & CKIN Condition



The A/D Converter operates data conversion when STCB(Start Conversion Bar) signal is just "HIGH". Otherwise, output data (DO[9:0]) keep the current states. The STCB signal should be changed during "T<sub>SAFE</sub>" with the "HIGH" level of the clock to operation as shown in the main waveform.

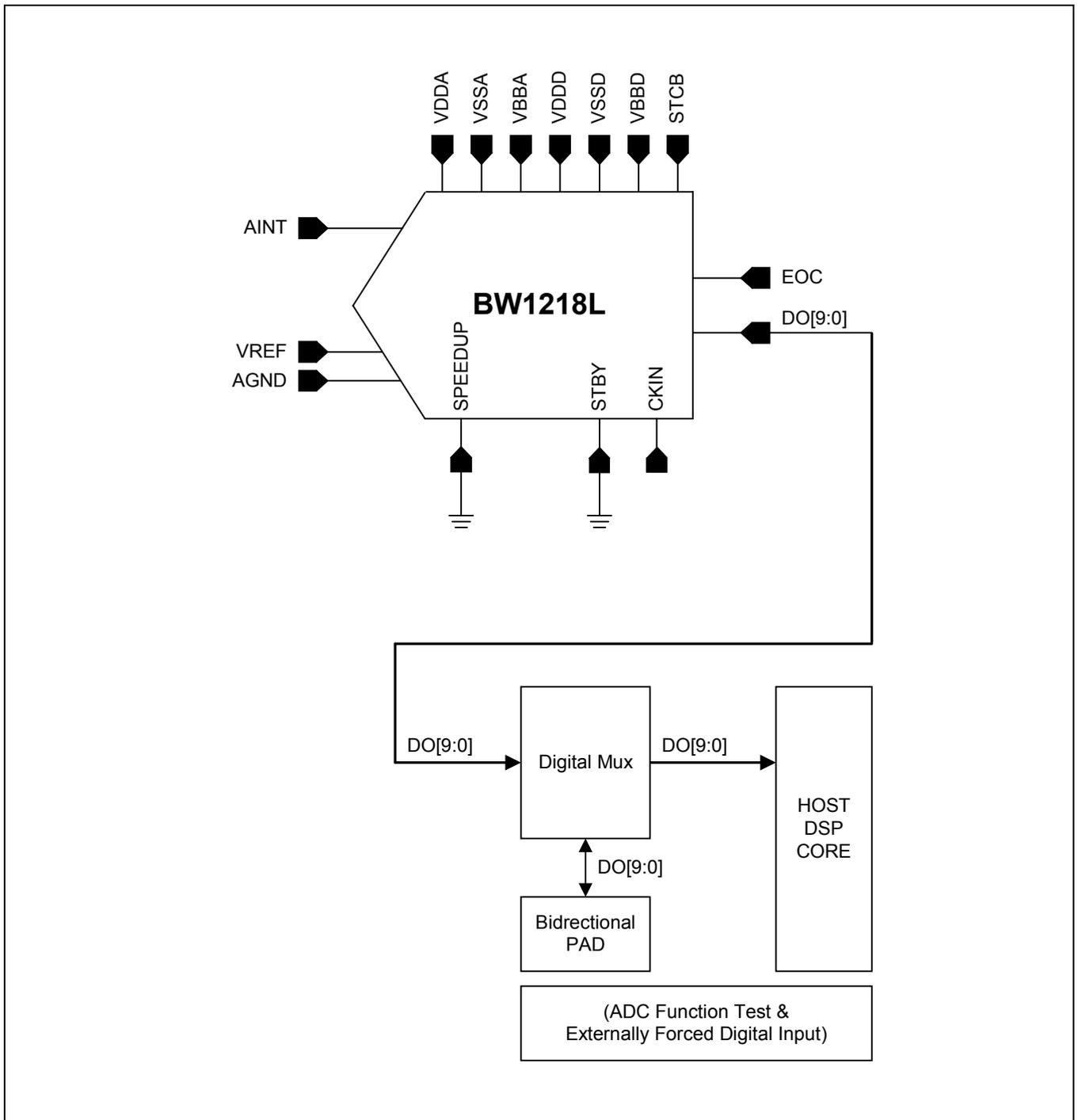
### 3. Pipeline Delay



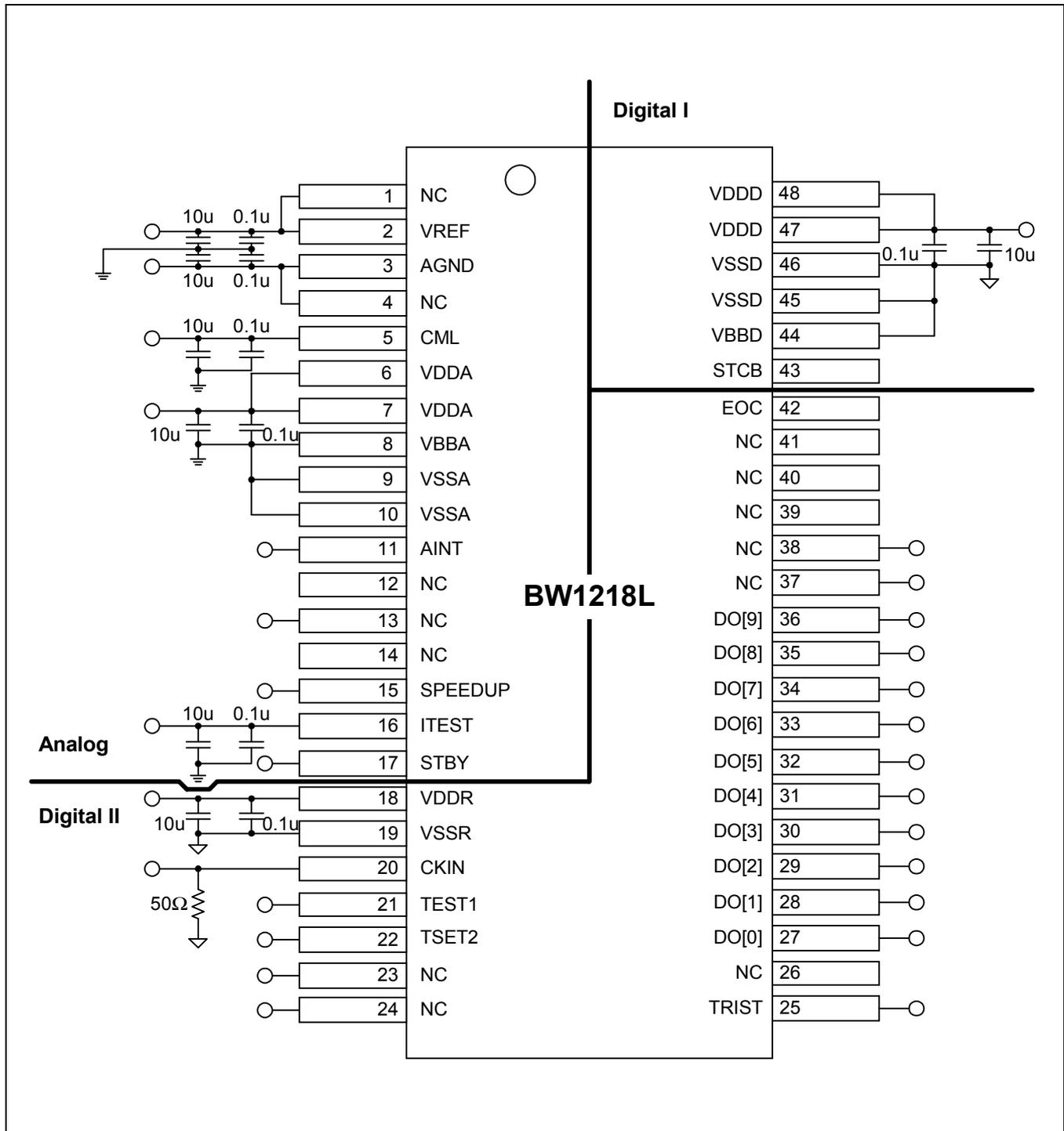
After STCB is "HIGH", the A/D Converter requires the pipeline delay of 3 clock period to generate EOC signal and data outputs.

### CORE EVALUATION GUIDE

1. ADC function is evaluated by external check on the bidirectional pads connected to input nodes of HOST DSP back-end circuit.
2. The reference voltages may be biased internally through resistor divider.



**PACKAGE CONFIGURATION**



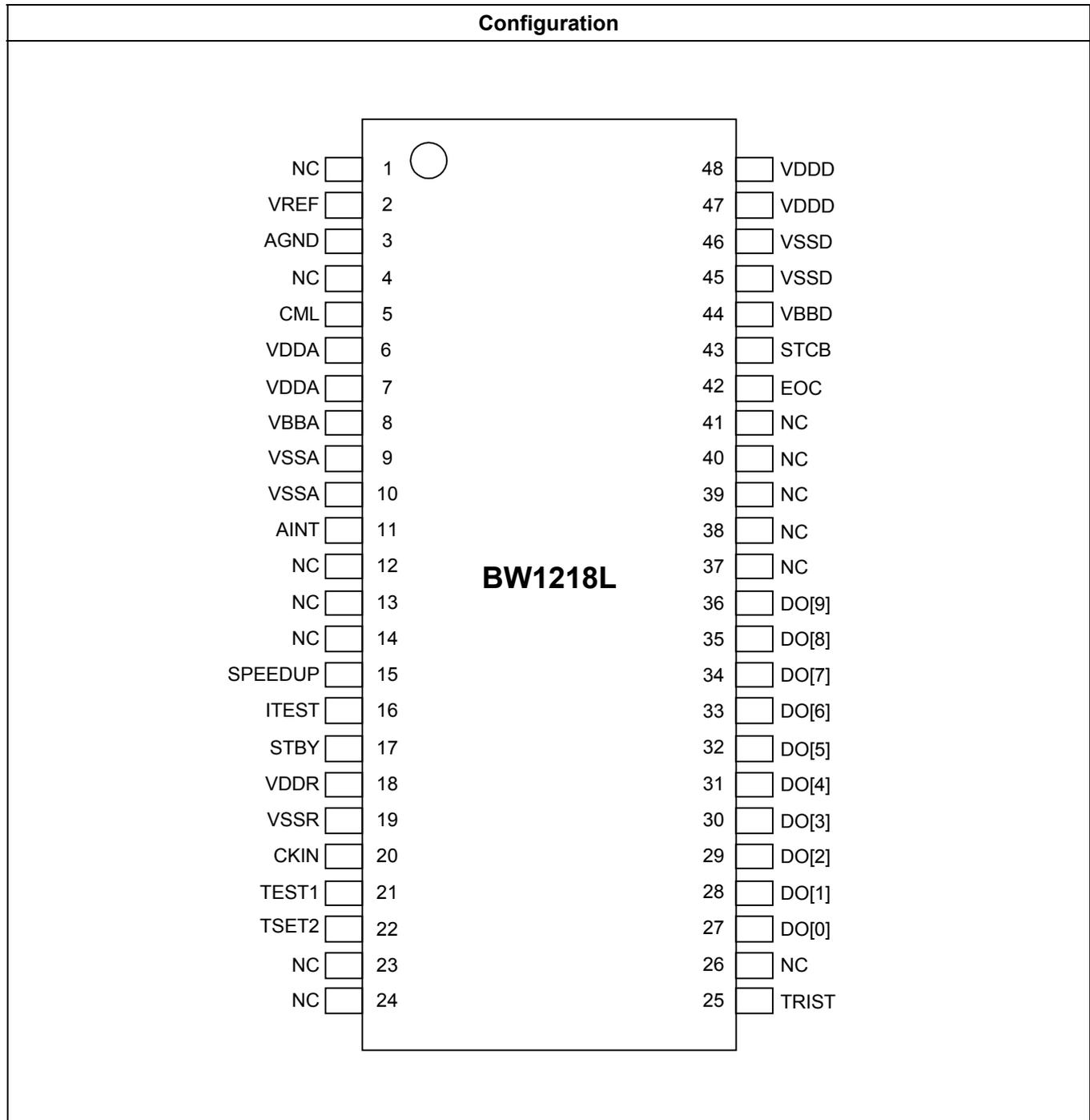
**NOTE:** NC denotes "No Connection".

**PACKAGE PIN DESCRIPTION**

Number	Name	I/O Type	Pin Description
2	VREF	AI	Reference Voltage (3.2V)
3	AGND	AI	Analog Ground for Reference
5	CML	AB	Internal Bias Point
6, 7	VDDA	AP	Analog Power (3.3V)
8	VBBA	AG	Analog Sub Bias
9, 10	VSSA	AG	Analog Ground
11	AINT	AI	Analog Input (0.0V~3.0V)
15	SPEEDUP	DI	VDD=Speed up, GND=Normal
16	ITEST	AB	open=use internal bias circuit
17	STBY	DI	VDD=Power saving (Standby), GND=Normal
18	VDDR	PP	PAD Power (3.3V)
19	VSSR	PG	PAD Ground
20	CKIN	DI	Sampling Clock Input
21	TEST1	AO	Monitoring (TEST) Cell Pin1, GND=Normal
22	TEST2	AO	Monitoring (TEST) Cell Pin2, GND=Normal
25	TRIST	DI	Tristate Buffer Input VDD=High Impedance, GND=Normal
27	DO[0]	DO	Digital Output (LSB)
28~5	DO[1:8]	DO	Digital Output
36	DO[9]	DO	Digital Output (MSB)
42	EOC	DO	End of Conversion Signal
43	STCB	DI	Start of Conversion Signal
44	VBBD	DG	Digital Sub Bias
45, 46	VSSD	DG	Digital GND
47, 48	VDDD	DP	Digital Power (3.3V)

**NOTE:** I/O TYPE PP and PG denote PAD Power and PAD Ground respectively.

**PACKAGE PIN DESCRIPTION (Continued)**



## USER GUIDE

### 1. Input Range

— The BW1218L use only the single-ended input, and input range is 0.0V ~ 3.0V (3.0V<sub>P-P</sub>).

### 2. Speed Up

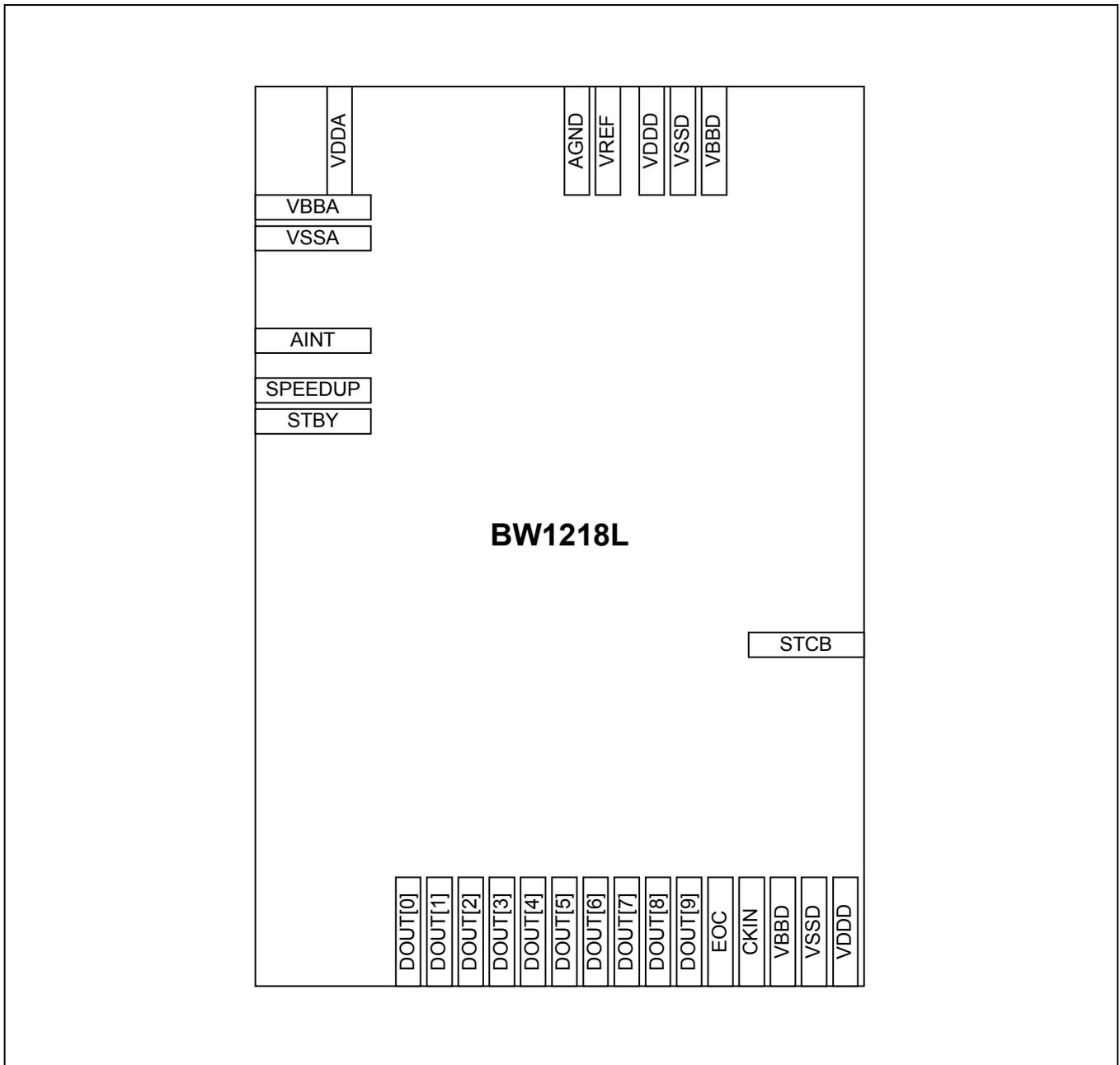
The initial target speed of BW1009L is 5 ~ 10MHz.

If you want more speed (about  $\geq$  10MHz), you should connect the SPEEDUP port to 'HIGH'.

### 3. Power Consumption Optimization

Yon can optimize the power consumption, as control the ITEST voltage level precisely .

PHANTOM CELL INFORMATION



**PHANTOM CELL INFORMATION (Continued)**

Pin Name	Pin Usage	Pin Layout Guide
VDDA	External	- Do not merge the analog powers with another power from other blocks. - Use good power and ground source on board.
VSSA	External	
VBBA	External	
VDDD	External	
VSSD	External	
VBBD	External	
AINT	External/Internal	- Do not overlap with digital lines. - Maintain the shortest path to pads.
VREF, AGND	External/Internal	- Maintain the larger width and the shorter length as far as the pads. - Separate from all other digital lines.
SPEEDUP	External/Internal	- Separate from all other analog signals
CKIN	External/Internal	
STBY	External/Internal	
STCB	External/Internal	
EOC	External/Internal	- Separated from the analog clean signals if possible.
ADO[9]	External/Internal	
ADO[8]	External/Internal	
ADO[7]	External/Internal	
ADO[6]	External/Internal	
ADO[5]	External/Internal	
ADO[4]	External/Internal	
ADO[3]	External/Internal	
ADO[2]	External/Internal	
ADO[1]	External/Internal	
ADO[0]	External/Internal	

## FEEDBACK REQUEST

### ADC Specification

Parameter	Min	Typ	Max	Unit	Remarks
Supply voltage				V	
Reference Input voltage				V	
Analog Input voltage				V <sub>pp</sub>	
Operating temperature				°C	
Integral non-linearity error				LSB	
Differential non-linearity error				LSB	
Offset voltage error (Bottom)				mV	
Offset voltage error (Top)				mV	
Maximum conversion rate				MSPS	
Dynamic supply current				mA	
Power dissipation				mW	
Signal-to-noise ratio				dB	
Digital output format (Provide detailed description & timing diagram)					

- What do you want to choose as power supply voltages? For example, the analog VDD needs to be 5V. the digital VDD can be 3.3V/5V.
- What resolution do you need for ADC?
- How about conversion speed (data in @ data out)?
- How many cycles do exist during the latency of ADC (pipelined delay)?
- What's the input range? And then what do you need between single input and differential input?
- Can the bus interface be compatible with TTL?
- Could you explain external/internal pin configurations as required?

Specially requested function list :



**NOTES**